

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under

Reexamination
OTSUKA ET AL.

Examiner

Thinh H Nguyen

Art Unit

2861

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
	A	US- -				
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		Country Code-Number-Kind Code	MM-YYYY				
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